SHEET 1 OF 1 INFORMATION DISCLOSURE ATTY. DOCKET NO. SERIAL NO. 62807-182 CITATION IN AN 10/812,425 **APPLICATION APPLICANT** Fusamitsu TSUBATA, et al. FILING DATE **GROUP** (PTO-1449) 2851 March 30, 2004 **U.S. PATENT DOCUMENTS EXAMINER'S** Document Number **Publication Date** Name of Patentee or Applicant of Cited Pages, Columns, Lines, Where INITIALS MM-DD-YYYY CITE Number-Kind Code2 (7 known) Document Relevant Passages or Relevant NO. Figures Appear US US us US US บร US US US US US US US US FOREIGN PATENT DOCUMENTS **EXAMINER'S** Foreign Patent Document **Publication Date** Pages, Columns, Lines Name of Patentee or Translation Country Codes -Number 4 -Kind Codes (if known) INITIALS Applicant of Cited Document CITE Where Relevant MM-DD-YYYY Figures Appear Yes No JP 2000-2932 A (w/ English 01/07/2000 SEIKO EPSON CORP. Abstract) JP 2001-264726 A (w/ 09/26/2001 NEC CORP. English Abstract) JP 2003-75696 A (w/ English 03/12/2003 SEIKO EPSON CORP. Abstract) OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.) Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, **EXAMINER'S** INITIALS journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where CITE

*EXAMINER: Initial if reference considered, Mether or not citation is in conformance with MFEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

DATE CONSIDERED

EXAMINER